Search Notes			

Application/Control N	No. Applicant(s)/Patent und Reexamination	er
10/717,955	VU, HA C.	
Examiner	Art Unit	
Hai L. Nguven	2816	

SEARCHED				
Class	Subclass	Date	Examiner	
327	115,117, 118,150, 145-148, 150	5/1/2005	HLN	
327	151,156			
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Class	Subclass	Date	Examiner
Search	Above	5/1/2005	HLN

SEARCH (INCLUDING SEAR		Y)
	DATE	EXMR
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